

Search Notes

Application/Control No.

10/756,051

Examiner

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Applicant(s)/Patent under
Reexamination

JENG, ERIK S.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
N/A			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
257/314-321,390 (text search only, see search history printout)	12/2/2005	LKT
257/275-278, E21.662,E21.666 - E21.678 (text search only, see search history printout)	12/7/2005	LKT
Interference Search History Printout	12/7/2005	LKT